

ACPL-M43T

Automotive Wide Operating Temperature 1MBd Digital Optocoupler in a 5-Pin Surface Mount Plastic Package



Data Sheet



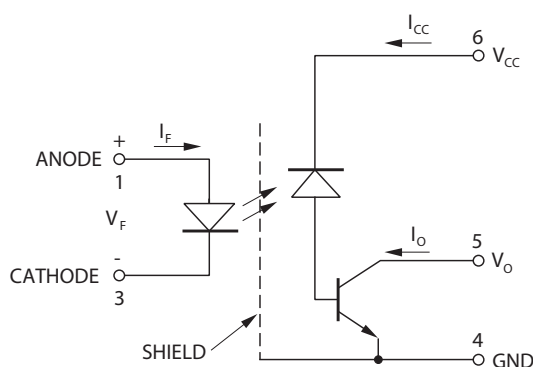
Description

The ACPL-M43T is a single channel, high temperature, high CMR, high speed digital optocoupler in a five lead miniature footprint specifically used in the automotive applications. The SO-5 JEDEC registered (MO-155) package outline does not require “through holes” in a PCB. This package occupies approximately one-fourth the footprint area of the standard dual-in-line package. The lead profile is designed to be compatible with standard surface mount processes.

This digital optocoupler uses an insulating layer between the light emitting diode and an integrated photon detector to provide electrical insulation between input and output. Separate connections for the photodiode bias and output transistor collector increase the speed up to a hundred times over that of a conventional photo-transistor coupler by reducing the base-collector capacitance.

The ACPL-M43T has an increased common mode transient immunity of 30kV/μs minimum at $V_{CM} = 1500V$ over extended temperature range.

Functional Diagram



Note: The connection of a 0.1 μF bypass capacitor between pins 4 and 6 is recommended.

Truth Table

LED	V _O
ON	LOW
OFF	HIGH

Features

- High Temperature and Reliability IPM Driver for Automotive Application.
- 30 kV/μs High Common-Mode Rejection at $V_{CM} = 1500 V$ (typ)
- Compact, Auto-Insertable SO5 Packages
- Wide Temperature Range: -40°C ~ 125°C
- High Speed: 1MBd (Typ)
- Low LED Drive Current: 10mA (typ)
- Low Propagation Delay: 300ns (typ)
- Worldwide Safety Approval:
 - UL1577 recognized, 3750Vrms/1min
 - CSA Approved
 - IEC/EN/DIN EN 60747-5-2 Approved

Applications

- Automotive IPM Driver for DC-DC converters and motor inverters
- CANBus Communications Interface
- High Temperature Digital/Analog Signal Isolation
- Power Transistor Isolation

CAUTION: It is advised that normal static precautions be taken in handling and assembly of this component to prevent damage and/or degradation which may be induced by ESD.

Ordering Information

Part number	Option		Package	Surface Mount	Gull Wing	Tape & Reel	UL 5000 Vrms / 1 Minute rating	IEC/EN/DIN EN 60747-5-2	Quantity
	RoHS Compliant	Non RoHS Compliant							
ACPL-M43T	-000E	No option	SO-5	X					100 per tube
	-500E	-500		X		X			1500 per reel

To order, choose a part number from the part number column and combine with the desired option from the option column to form an order entry.

Example 1:

ACPL-M43T-500E to order product of Mini-flat Surface Mount 5-pin package in Tape and Reel packaging with RoHS compliant.

Example 2:

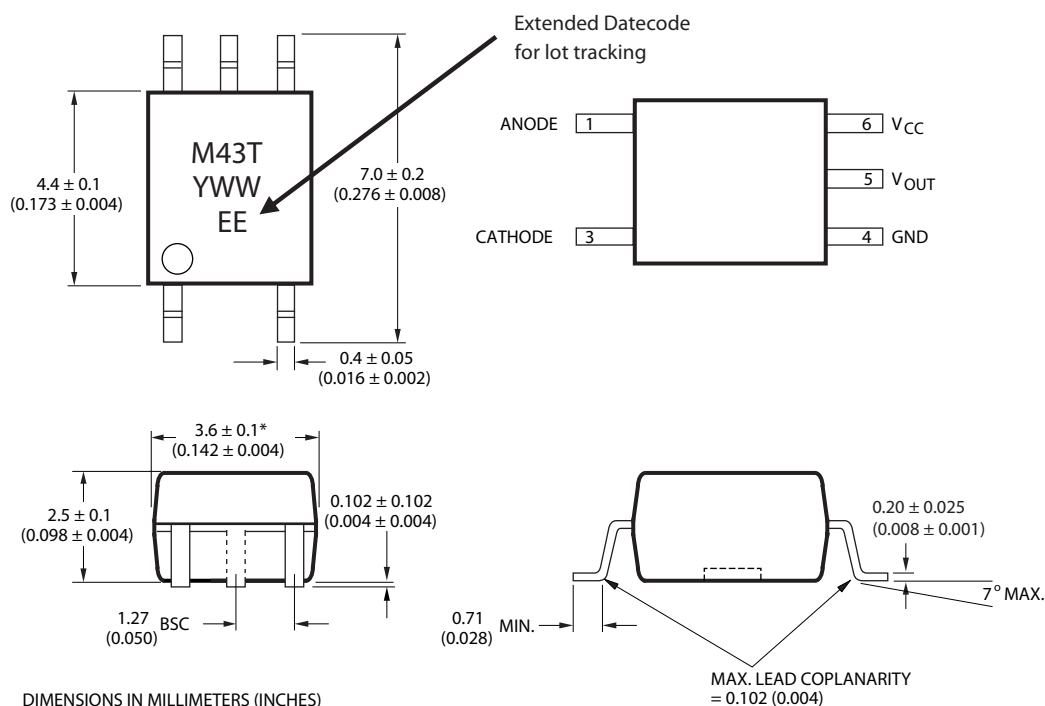
ACPL-M43T to order product of Mini-flat Surface Mount 5-pin package in tube packaging and non RoHS compliant.

Option datasheets are available. Contact your Avago sales representative or authorized distributor for information.

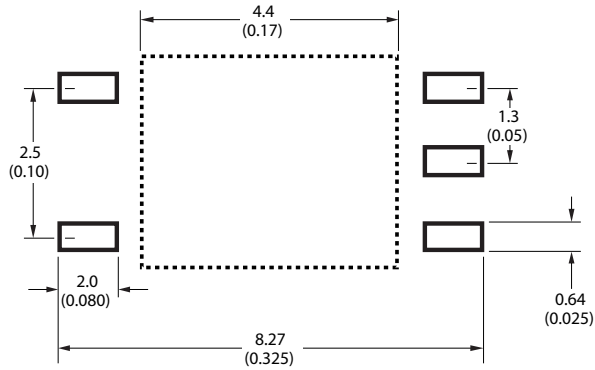
Remarks: The notation '#XXX' is used for existing products, while (new) products launched since 15th July 2001 and RoHS compliant option will use '-XXxE'.

Package Outline Drawings

ACPL-M43T Small Outline SO-5 Package (JEDEC MO-155)

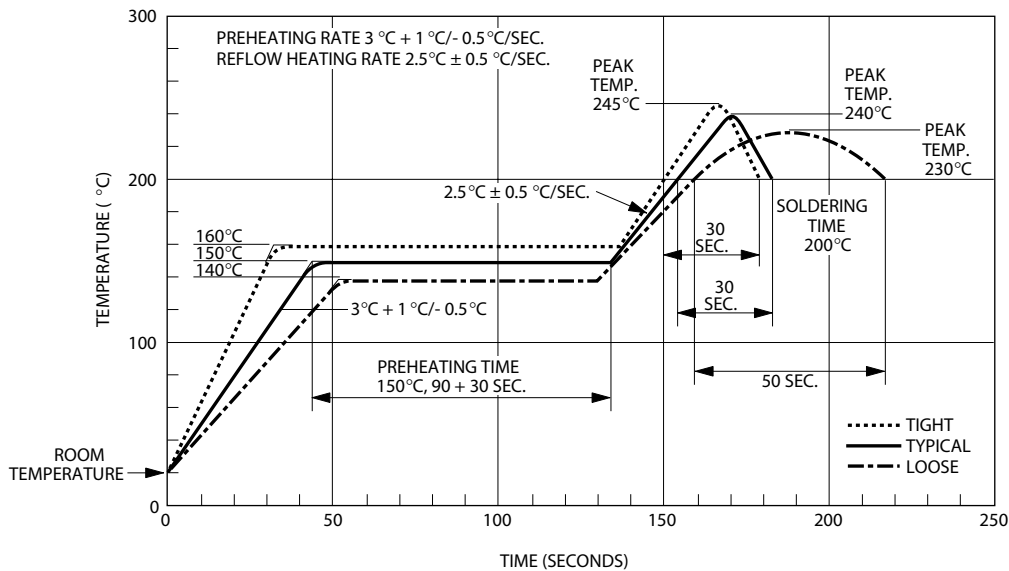


Land Pattern Recommendation



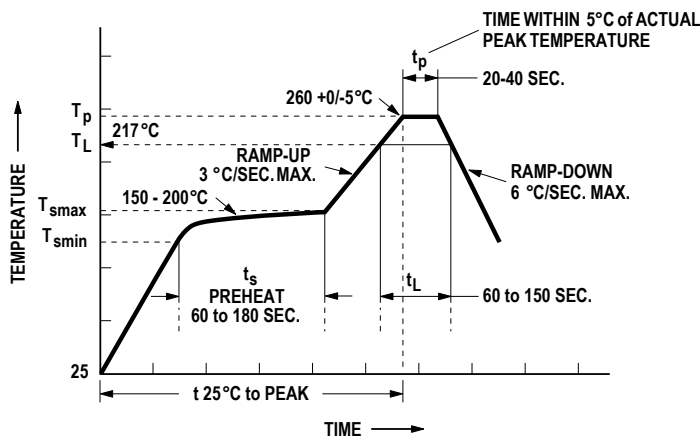
DIMENSIONS IN MILLIMETERS AND (INCHES)

Solder Reflow Temperature Profile



Note: Non-halide flux should be used.

Recommended Pb-Free IR Profile



NO TES:
THE TIME FROM 25°C to PEAK TEMPERATURE = 8 MINUTES MAX.
 $T_{smax} = 200^{\circ}\text{C}$, $T_{smin} = 150^{\circ}\text{C}$

Note: Non-halide flux should be used.

Regulatory Information

The ACPL-M43T is approved by the following organizations:

UL

Approved under UL 1577, component recognition program up to $V_{ISO} = 3750 V_{RMS}$ expected prior to product release..

CSA

Approved under CSA Component Acceptance Notice #5.

IEC/EN/DIN EN 60747-5-2

Approved under:
IEC 60747-5-2:1997 + A1
EN 60747-5-2:2001 + A1
DIN EN 60747-5-2 (VDE 0884 Teil 2)

IEC/EN/DIN EN 60747-5-2 Insulation Characteristics*

Description	Symbol	Characteristic	Unit
Installation classification per DIN VDE 0110/1.89, Table 1 for rated mains voltage $\leq 150 V_{RMS}$ for rated mains voltage $\leq 300 V_{RMS}$ for rated mains voltage $\leq 600 V_{RMS}$		I – IV I – III I – II	
Climatic Classification		55/125/21	
Pollution Degree (DIN VDE 0110/1.89)		2	
Maximum Working Insulation Voltage	V_{IORM}	567	V_{peak}
Input to Output Test Voltage, Method b* $V_{IORM} \times 1.875 = V_{PR}$, 100% Production Test with $t_m = 1$ sec, Partial discharge < 5 pC	V_{PR}	1063	V_{peak}
Input to Output Test Voltage, Method a* $V_{IORM} \times 1.5 = V_{PR}$, Type and Sample Test, $t_m = 60$ sec, Partial discharge < 5 pC	V_{PR}	851	V_{peak}
Highest Allowable Overvoltage (Transient Overvoltage $t_{ini} = 10$ sec)	V_{IOTM}	6000	V_{peak}
Safety-limiting values – maximum values allowed in the event of a failure.			
Case Temperature	T_S	175	$^{\circ}C$
Input Current	$I_{S, INPUT}$	230	mA
Output Power	$P_{S, OUTPUT}$	600	mW
Insulation Resistance at T_S , $V_{IO} = 500$ V	RS	$> 10^9$	Ω

* Refer to the optocoupler section of the Isolation and Control Components Designer's Catalog, under Product Safety Regulations section, (IEC/EN/DIN EN 60747-5-2) for a detailed description of Method a and Method b partial discharge test profiles.

Insulation and Safety Related Specifications

Parameter	Symbol	ACPL-M43T	Units	Conditions
Minimum External Air Gap (Clearance)	L(101)	≥ 5	mm	Measured from input terminals to output terminals, shortest distance through air.
Minimum External Tracking (Creepage)	L(102)	≥ 5	mm	Measured from input terminals to output terminals, shortest distance path along body.
Minimum Internal Plastic Gap (Internal Clearance)		0.08	mm	Through insulation distance conductor to conductor, usually the straight line distance thickness between the emitter and detector.
Tracking Resistance (Comparative Tracking Index)	CTI	175	V	DIN IEC 112/VDE 0303 Part 1
Isolation Group (DIN VDE0109)		IIIa		Material Group (DIN VDE 0109)

Absolute Maximum Ratings

Parameter	Symbol	Min.	Max.	Units	Note
Storage Temperature	T_S	-55	150	°C	
Operating Temperature	T_A	-40	125	°C	
Lead Soldering Cycle	Temperature		260	°C	
	Time		10	s	
Average Forward Input Current	$I_{F(avg)}$		20	mA	1
Peak Forward Input Current (50% duty cycle, 1ms pulse width)	$I_{F(peak)}$		40	mA	2,
Peak Transient Input Current ($\leq 1\mu s$ pulse width, 300ps)	$I_{F(trans)}$		100	mA	
Reversed Input Voltage	V_R		5	V	Pin 3 - 1
Input Power Dissipation	P_{IN}		30	mW	3
Output Power Dissipation	P_O		100	mW	4
Average Output Current	I_O		8	mA	
Peak Output Current	$I_{O(pk)}$		16	mA	
Supply Voltage (Pins 6-4)	V_{CC}	-0.5	30	V	
Output Voltage (Pins 5-4)	V_O	-0.5	20	V	
Solder Reflow Temperature Profile	See Reflow Temperature Profile				

Recommended Operating Conditions

Parameter	Symbol	Min.	Max.	Units	Note
Supply Voltage	V_{CC}	4.5	15.0	V	
Operating Temperature	T_A	-40	125	°C	

Electrical Specifications (DC)

Over recommended operating $T_A = -40^{\circ}\text{C}$ to 125°C , unless otherwise specified.

Parameter	Sym.	Min.	Typ.	Max.	Units	Conditions	Fig.	Note
Current Transfer Ratio	CTR	32	45	80	%	$T_A=25^{\circ}\text{C}$ $V_o=0.4\text{V}$	$V_{CC}=4.5\text{V}$ $I_F=10\text{mA}$	1,2,4 5
		20	45		%	$V_o=0.5\text{V}$		
Logic Low Output Voltage	V_{OL}		0.1	0.4	V	$T_A=25^{\circ}\text{C}$ $I_o=3\text{mA}$		
				0.5	V	$I_o=2.4\text{mA}$		
Logic High Output Current	I_{OH}		0.003	0.5	μA	$T_A=25^{\circ}\text{C}$ $V_o=V_{CC}=5.5\text{V}$	$I_F=0\text{mA}$	7
			0.01	1	μA	$T_A=25^{\circ}\text{C}$ $V_o=V_{CC}=15\text{V}$		
				50	μA			
Logic Low Supply Current	I_{CCL}		50	200	μA	$I_F=10\text{mA}$, $V_o=\text{open}$, $V_{CC}=15\text{V}$		11
Logic High Supply Current	I_{CCH}		0.02	1	μA	$T_A=25^{\circ}\text{C}$ $I_F=0\text{mA}$, $V_o=\text{open}$, $V_{CC}=15\text{V}$		11
				2.5	μA			
Input Forward Voltage	V_F	1.45	1.5	1.85	V	$T_A=25^{\circ}\text{C}$ $I_F=10\text{mA}$	3	
		1.35	1.5	1.95	V	$I_F=10\text{mA}$		
Input Reversed Breakdown Voltage	BV_R	5			V	$I_R=10\mu\text{A}$		
Temperature Coefficient of Forward Voltage	$\Delta V / \Delta T_A$		-1.5		$\text{mV}/^{\circ}\text{C}$	$I_F=10\text{mA}$		
Input Capacitance	C_{IN}		90		pF	$F=1\text{MHz}$, $V_F=0$		
Input-Output Insulation	V_{ISO}	3750			V_{RMS}	$RH \leq 50\%$, $t=1\text{min}$, $T_A=25^{\circ}\text{C}$		6,7
Resistance (Input-Output)	R_{I-O}		10^{12}		Ω	$V_{I-O} = 500V_{DC}$		6
Capacitance (Input-Output)	C_{I-O}		0.6		pF	$F=1\text{MHz}$		6

Switching Specifications (AC)

Over recommended operating ($T_A = -40^{\circ}\text{C}$ to 125°C), $I_F = 10\text{mA}$, $V_{CC} = 5.0\text{V}$ unless otherwise specified.

Parameter	Symbol	Min	Typ	Max	Units	Test Conditions	Fig.	Note
Propagation Delay Time to Logic Low at Output	T_{PHL}	0.08 0.06	0.2	0.8 1.0	μs μs	$T_A = 25^{\circ}\text{C}$ Pulse: $f = 10\text{kHz}$, Duty cycle = 50%, $I_F = 10\text{mA}$, $V_{CC} = 5.0\text{V}$, $R_L = 1.9\text{k}\Omega$, $C_L = 15\text{pF}$ $V_{THL} = 1.5\text{V}$	5, 6, 8	9
Propagation Delay Time to Logic High at Output	T_{PLH}	0.15 0.03	0.3	0.8 1.0	μs μs	$T_A = 25^{\circ}\text{C}$ Pulse: $f = 10\text{kHz}$, Duty cycle = 50%, $I_F = 10\text{mA}$, $V_{CC} = 5.0\text{V}$, $R_L = 1.9\text{k}\Omega$, $C_L = 15\text{pF}$ $V_{THL} = 2.0\text{V}$	5, 6, 8	9
Pulse Width Distortion	PWD	0 0	0.4	0.45 0.85	μs μs	$T_A = 25^{\circ}\text{C}$ Pulse: $f = 10\text{kHz}$, Duty cycle = 50%, $I_F = 10\text{mA}$, $V_{CC} = 5.0\text{V}$, $R_L = 1.9\text{k}\Omega$, $C_L = 15\text{pF}$, $V_{THL} = 1.5\text{V}$, $V_{TLH} = 2.0\text{V}$		12
Propagation Delay Difference Between Any 2 Parts	$t_{PLH} - t_{PHL}$	0 0	0.4	0.5 0.9	μs μs	$T_A = 25^{\circ}\text{C}$ Pulse: $f = 10\text{kHz}$, Duty cycle = 50%, $I_F = 10\text{mA}$, $V_{CC} = 5.0\text{V}$, $R_L = 1.9\text{k}\Omega$, $C_L = 15\text{pF}$, $V_{THL} = 1.5\text{V}$, $V_{TLH} = 2.0\text{V}$		13
Common Mode Transient Immunity at Logic High Output	$ CM_H $	15	30		$\text{kV}/\mu\text{s}$	$V_{CM} = 1500\text{Vp-p}$, $I_F = 0\text{mA}$, $T_A = 25^{\circ}\text{C}$, $R_L = 1.9\text{k}\Omega$	9	8, 9
Common Mode Transient Immunity at Logic Low Output	$ CM_L $	15	30		$\text{kV}/\mu\text{s}$	$V_{CM} = 1500\text{Vp-p}$, $I_F = 10\text{mA}$, $T_A = 25^{\circ}\text{C}$, $R_L = 1.9\text{k}\Omega$		

Package Characteristics

*The Input-Output Momentary Withstand Voltage is a dielectric voltage rating that should not be interpreted as an input-output continuous voltage rating.

Parameter	Symbol	Min.	Typ.	Max.	Units	Test Conditions	Fig.	Note
Input-Output Momentary Withstand Voltage*	V_{ISO}	3750			V_{rms}	$R_H \leq 50\%$, $t = 1\text{ min}$; $T_A = 25^{\circ}\text{C}$		6, 7
Input-Output Resistance	R_{I-O}		10^{12}		Ω	$V_{I-O} = 500\text{Vdc}$		6
Input-Output Capacitance	C_{I-O}		0.6		pF	$f = 1\text{ MHz}$; $V_{I-O} = 0\text{Vdc}$		6

Notes:

- Derate linearly above 85°C free-air temperature at a rate of $0.25\text{ mA}/^{\circ}\text{C}$.
- Derate linearly above 85°C free-air temperature at a rate of $0.30\text{ mA}/^{\circ}\text{C}$.
- Derate linearly above 85°C free-air temperature at a rate of $0.375\text{ mW}/^{\circ}\text{C}$.
- Derate linearly above 85°C free-air temperature at a rate of $1.875\text{ mW}/^{\circ}\text{C}$.
- CURRENT TRANSFER RATIO in percent is defined as the ratio of output collector current, I_O , to the forward LED input current, I_F , times 100.
- Device considered a two terminal device: pins 1 and 3 shorted together, and pins 4, 5 and 6 shorted together.
- In accordance with UL 1577, each optocoupler is proof tested by applying an insulation test voltage $\geq 4500 V_{RMS}$ for 1 second (leakage detection current limit, $I_{I-O} \leq 5\text{ }\mu\text{A}$).
- Common transient immunity in a Logic High level is the maximum tolerable (positive) dV_{CM}/dt on the rising edge of the common mode pulse, V_{CM} , to assure that the output will remain in a Logic High state (i.e., $V_O > 2.0\text{V}$). Common mode transient immunity in a Logic Low level is the maximum tolerable (negative) dV_{CM}/dt on the falling edge of the common mode pulse signal, V_{CM} to assure that the output will remain in a Logic Low state (i.e., $V_O < 0.8\text{V}$).
- The $1.9\text{ k}\Omega$ load represents 1 TTL unit load of 1.6 mA and the $5.6\text{ k}\Omega$ pull-up resistor.
- The frequency at which the ac output voltage is 3 dB below its mid-frequency value.
- Use of a $0.1\text{ }\mu\text{F}$ bypass capacitor connected between pins 4 and 6 is recommended.
- Pulse Width Distortion (PWD) is defined as $|t_{PHL} - t_{PLH}|$ for any given device.
- The difference between t_{PLH} and t_{PHL} between any two parts under the same test condition.

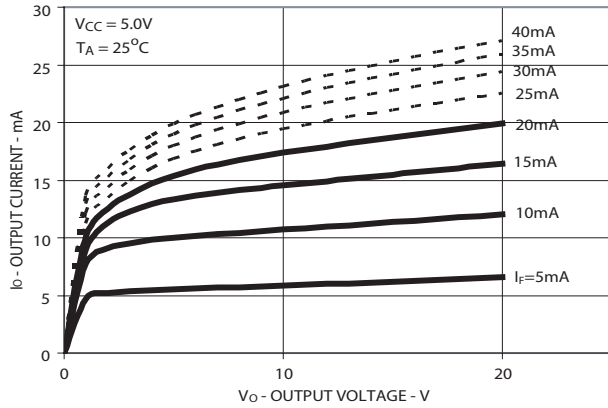


Figure 1. DC and Pulsed Transfer Characteristics.

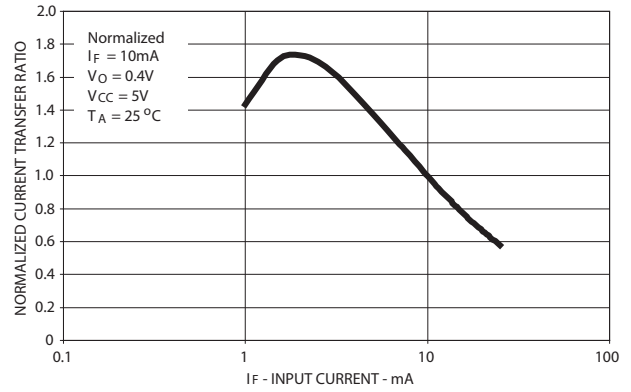


Figure 2. Current Transfer Ratio vs Input Current

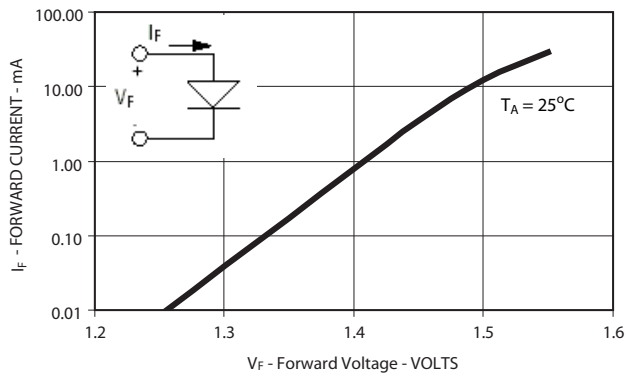


Figure 3. Input Current vs Forward Voltage

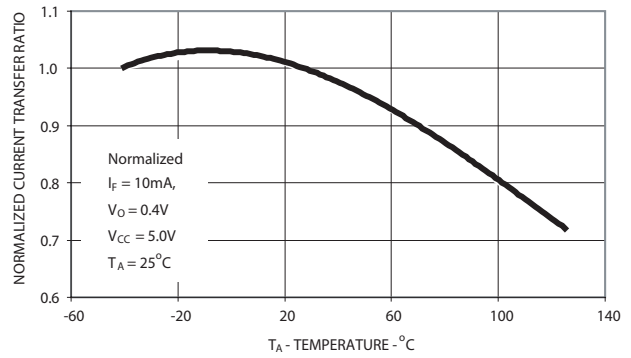


Figure 4. Current Transfer Ratio vs Temperature

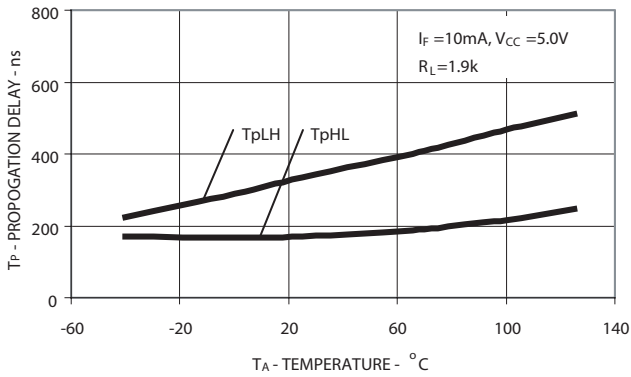


Figure 5. Propagation Delay vs Temperature

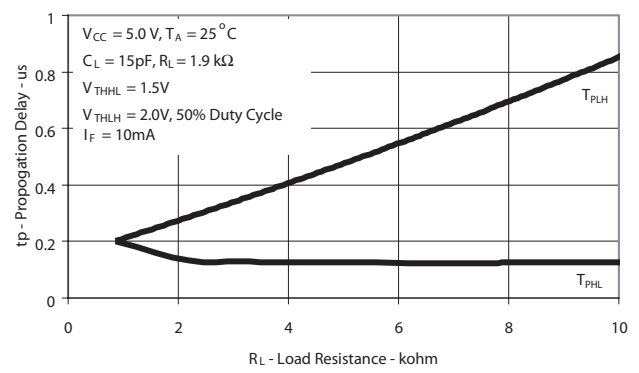


Figure 6. Propagation Delay Time vs Load Resistance

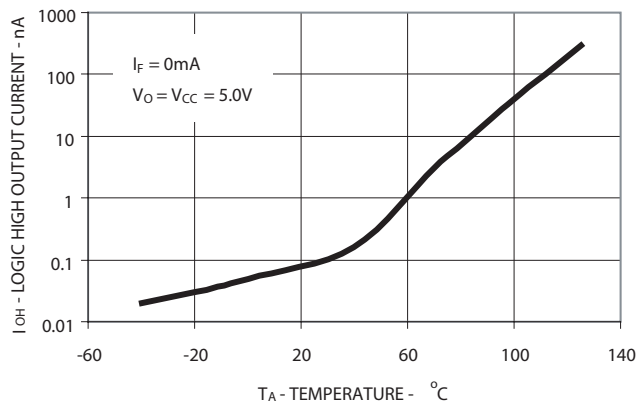


Figure 7. Logic High Output Current vs Temperature.

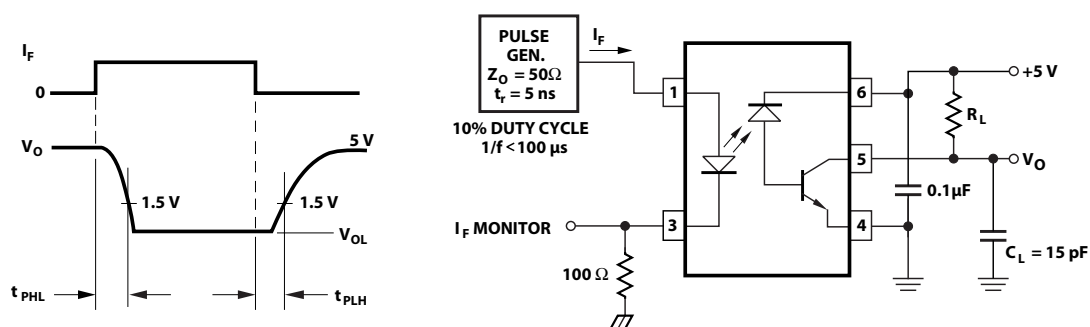


Figure 8. Switching Test Circuit

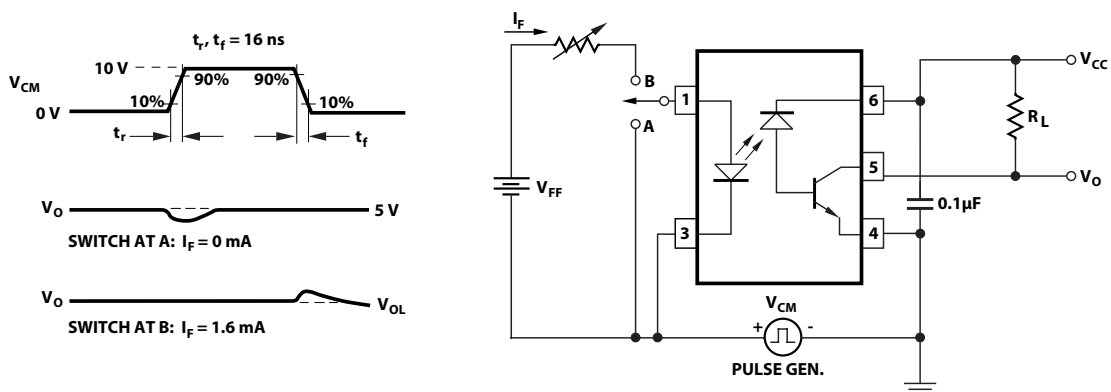


Figure 9. Test Circuit for Transient Immunity and Typical Waveforms.

For product information and a complete list of distributors, please go to our web site: www.avagotech.com

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